

AUTOMOTIVE CURRENT TRANSDUCER OPEN LOOP TECHNOLOGY

HAH3DR 300-S0E, HAH3DR 600-S0E, HAH3DR 700-S0E, HAH3DR 800-S0E, HAH3DR 900-S0E, HAH3DR 1000-S0E, HAH3DR 1100-S0E, HAH3DR 1200-S0E





Introduction

The HAH3DR-S0E series is a tri-phase transducer for DC, AC, or pulsed currents measurement in high power and low voltage automotive applications. It offers a galvanic separation between the primary circuit (high power) and the secondary circuit (electronic circuit).

The HAH3DR-S0E family gives you a choice of having different current measuring ranges in the same housing (from \pm 300 up to \pm 1200 A).

Features

- · Open Loop transducer using the Hall effect sensor
- Low voltage application
- Unipolar +5 V DC power supply
- Maximum RMS primary admissible current: defined by the busbar, the magnetic core or ASIC T < +150 °C
- Operating temperature range: $-40 \degree C < T < +125 \degree C$
- Output voltage: fully ratio-metric (in sensitivity and offset).

Special feature

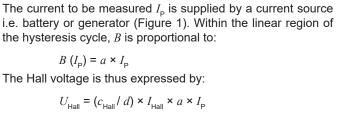
• Tri-phase transducer.

Advantages

- Excellent accuracy
- Very good linearity
- Very low thermal offset drift
- Very low thermal sensitivity drift
- High frequency bandwith
- No insertion losses
- Very fast delay time.

Automotive applications

- Starter Generators
- Inverters
- HEV applications
- EV applications
- DC / DC converter.



The open loop transducers use a Hall effect integrated circuit.

The magnetic flux density *B*, contributing to the rise of the Hall

voltage, is generated by the primary current I_{P} to be measured.

Except for $I_{\rm p}$, all terms of this equation are constant. Therefore:

Principle of HAH3DR S0E Series

< I _P
constant
constant
Hall coefficient
thickness of the Hall plate
current across the Hall plates

The measurement signal $U_{\rm Hall}$ amplified to supply the user output voltage or current.

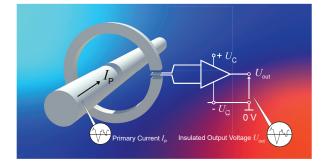
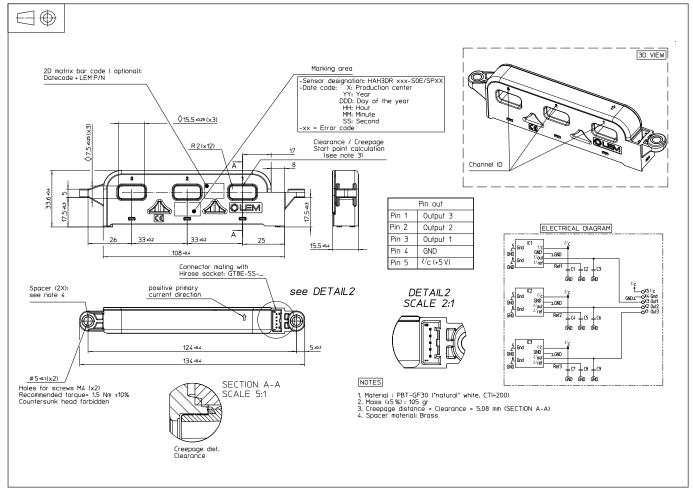


Fig. 1: Principle of the open loop transducer



Dimensions (in mm)



Mechanical characteristics

- Plastic case >PBT-GF 30< (natural)
- Magnetic core
 FeSi wound core
- Pins Copper alloy gold plated
- Mass 105 g ±5 %

Mounting recommendation

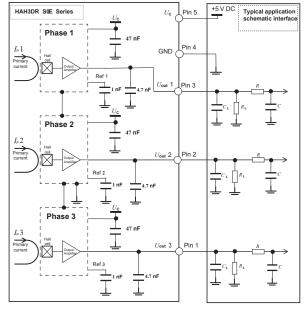
- Mating connector type Hirose Socket GT8E-5S-...
- Assembly torque max 1.5 N·m ±10 %
- The clamping force must be applied to the compression limiter, washer recommended.
- $R_{\rm I}$ > 10 k Ω optional resistor for signal line diagnostic
- $\bar{C_L}$ < 2.2 nF EMC protection
- RC: low pass filter (optional)

Capacitor U _{ref} / Gnd	1 nF
Capacitor U _c / Gnd	47 nF
Capacitor U _{out} / Gnd	4.7 nF

Remark

U_{out} > U_O when I_P flows in the positive direction (see arrow on drawing).

System architecture (example)





Absolute ratings (not operating)

HAH3DR 300-S0E...1200-S0E

Parameter	Symbol	Unit	5	Specification		Conditions
Farameter	Symbol	onin	Min	Typical	Max	Conditions
			-0.5		8	Continuous not operating
Maximum supply voltage	$U_{\rm Cmax}$	V			6.5	Exceeding this voltage may temporarily reconfigure the circuit until the next power on
Output voltage low 1)	U _{out L}	V			0.2	@ $U_{\rm c} = 5 \text{ V}, T_{\rm A} = 25 \text{ °C}$
Output voltage high ¹⁾	U _{out H}	V	4.8			$U_{\rm C} = 3 V, I_{\rm A} = 23 C$
Ambient storage temperature	T _{Ast}	°C	-50		125	
Electrostatic discharge voltage (HBM)	$U_{\rm ESD\;HBM}$	kV			2	JESD 22-A 114-B class 2
RMS voltage for AC insulation test	$U_{\rm d}$	kV			2.5	50 Hz, 1 min, IEC 60664 part 1
Creepage distance	d _{Cp}	mm		5.08		
Clearance	d _{CI}	mm]	5.00		
Comparative tracking index	CTI		PLC 3			
Insulation resistance	R _{INS}	MΩ	500			500 V DC, ISO 16750
Primary withstand peak current (maximum)	$\hat{I}_{\rm Pmax}$	А			2)	

Operating characteristics in nominal range (I_{PN})

		Unit	5	Specificat	ion	
Parameter	Symbol		Min	Typical	Max	Conditions
		Elect	rical Da	ita		
Supply voltage 1)	U _c	V	4.75	5	5.25	
Ambient operating temperature	T _A	°C	-40		125	
Load capacitance	CL	nF			2.2	
Output voltage (Analog) ¹⁾	$U_{\rm out}$	V	$U_{\rm out}$ = (U _c / 5) × (U	$(+ S \times I_{P})$	@ U _c
Offset voltage	Uo	V		2.5		
Current consumption (for 3 phases)	I _c	mA		45	60	@ $U_{\rm c}$ = 5 V, @ -40 ° C < $T_{\rm A}$ < 125 °C
Load resistance	RL	KΩ	10			
Output internal resistance	R _{out}	Ω			10	DC to1 kHz
Per	formance D	ata @ 3	Sigma (in	cluding phas	es coupling)	
Ratiometricity error	€ _r	%		0.5		
		%		±0.5		@ T _A = 25 °C
Sensitivity error	ε _s			±1		@ $T_A = 25 \degree$ C, After $T \degree$ Cycles
Electrical offset voltage	U _{oe}	mV		±4		@ T _A = 25 °C, @ U _c = 5 V
Magnetic offset voltage	U _{o M}	mV	-7.5		7.5	@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V
Average temperature coefficient of U_{OF}	TCU _{OEAV}	mV/°C	-0.08		0.08	@ -40 ° C < T _A < 125 °C
Average temperature coefficient of S	TCS _{AV}	%/°C	-0.03	±0.01	0.03	@ -40 ° C < T _A < 125 °C
	_	0/ 7	-3		3	of Full range, $I_{\rm P}$ > 900 A or < –900 A @ $U_{\rm C}$ = 5 V, @ $T_{\rm A}$ = 25 °C
Linearity error	ÊL	% I _P	-1		1	of Full range, -900 A $\leq I_{p} \leq$ 900 A @ U_{c} = 5 V, @ T_{A} = 25 °C
Delay time to 90 % of the final output value for $I_{\rm PN}$ step	t _{D 90}	μs		4	6	$di/dt = 100 \text{ A/}\mu\text{s}$
Frequency bandwidth ²⁾	BW	kHz	40			@ -3 dB
Peak-to-peak noise voltage	U _{no pp}	mV			10	@ DC to 1 MHz
Phase shift	$\Delta \varphi$	0	-4		0	@ DC to 1 KHz

Notes: ¹⁾ The output voltage U_{out} , the offset voltage U_{o_c} the sensitivity S and the output voltage low/high $U_{out L+H}$ are fully ratiometric and dependant of the supply voltage U_c according the the following formula:

$$I_{\mathsf{P}} = \left(\frac{5}{U_{\mathsf{C}}} \times U_{\mathsf{out}} - U_{\mathsf{O}}\right) \times \frac{1}{S} \text{ with } S \text{ in (V/A)}$$

- ²⁾ Primary current frequencies must be limited in order to avoid excessive heating of the busbar, magnetic core and the ASIC (see feature paragraph in page 1)
- ³⁾ Transducer is not protected against reverse polarity.



Parameter	Symbol	Unit		Specification	Conditions					
	Symbol	Unit	Min	Typical	Max	Conditions				
Performance Data										
Primary current, measuring range	I _{PM}	A	-300		300					
Primary nominal RMS current	I _{PN}	A	-300		300					
Sensitivity	S	mV/A		6.67						

HAH3DR 600-S0E

HAH3DR 300-S0E

Parameter	Symbol	Unit		Specificatior	1	Conditions
	Symbol	Unit	Min	Typical	Max	Conditions
		Perfor	nance Data			
Primary current, measuring range	I _{PM}	A	-600		600	
Primary nominal RMS current	I _{PN}	A	-600		600	
Sensitivity	S	mV/A		3.33		

HAH3DR 700-S0E

Parameter	Symbol	vmbol Unit		Specificatior		Conditions
		Unit	Min	Typical	Max	Conditions
		Perfor	mance Data			
Primary current, measuring range	I _{PM}	A	-700		700	
Primary nominal RMS current	I _{PN}	A	-700		700	
Sensitivity	S	mV/A		2.86		

HAH3DR 800-S0E

Parameter	Symbol	Symbol Unit		Specificatior		Conditions				
	Symbol	Unit	Min	Typical	Max	Conditions				
Performance Data										
Primary current, measuring range	I _{PM}	A	-800		800					
Primary nominal RMS current	I _{PN}	A	-800		800					
Sensitivity	S	mV/A		2.50						

HAH3DR 900-S0E

Parameter	Symbol	Unit		Specification		Conditions
		Unit	Min	Typical	Max	Conditions
		Perforr	nance Data			
Primary current, measuring range	I _{PM}	A	-900		900	
Primary nominal RMS current	I _{pn}	А	-900		900	
Sensitivity	S	mV/A		2.22		

HAH3DR 1000-S0E

Parameter	Symbol	Unit	Specification			Conditions
		Unit	Min	Typical	Max	Conditions
	-	Perfori	mance Data	-		
Primary current, measuring range	I _{PM}	A	-1000		1000	
Primary nominal RMS current	I _{PN}	A	-1000		1000	
Sensitivity	S	mV/A		2.00		

HAH3DR 1100-S0E

Parameter	Symbol	Unit	Specification			Conditions
	Symbol	Unit	Min	Typical	Max	Conditions
		Perfori	mance Data			
Primary current, measuring range	$I_{\rm PM}$	A	-1100		1100	
Primary nominal RMS current	I _{pn}	A	-1100		1100	
Sensitivity	S	mV/A		1.82		

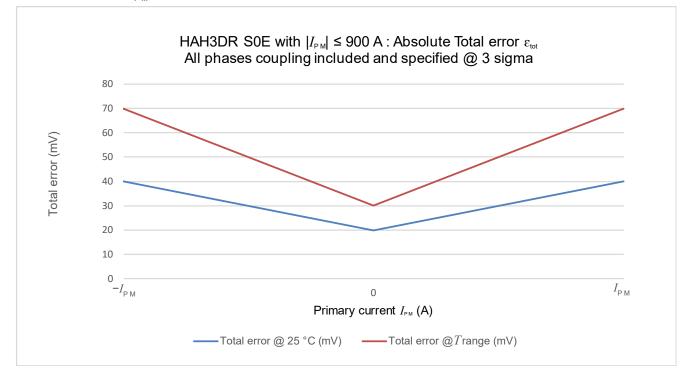
HAH3DR 1200-S0E

Parameter	Symbol	Unit	Specification			Conditions
	Symbol	Unit	Min	Typical	Max	Conditions
		Perform	mance Data			
Primary current, measuring range	I _{PM}	A	-1200		1200	
Primary nominal RMS current	I _{pn}	A	-1200		1200	
Sensitivity	S	mV/A		1.67		



Total error(mV) for $I_{PM} \leq 900 \text{ A}$

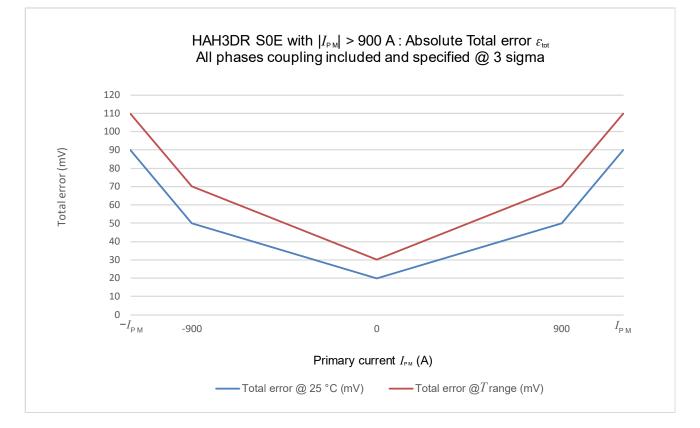




	Total error ε_{tot} specification			
I _Р (А)	$T_{\rm A}$ = 25 °C, $U_{\rm c}$ = 5 V		-40 °C < $T_{\rm A}$ < 125 °C, $U_{\rm C}$ = 5 V	
– I _{P M}	±40 mV	2 %	±70 mV	3.5 %
0	±20 mV	1 %	±30 mV	1.5 %
I _{PM}	±40 mV	2 %	±70 mV	3.5 %



Total error(mV) for $I_{PM} > 900 \text{ A}$

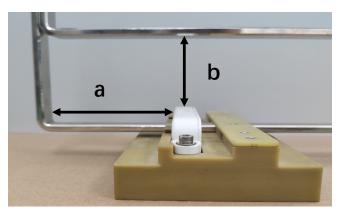


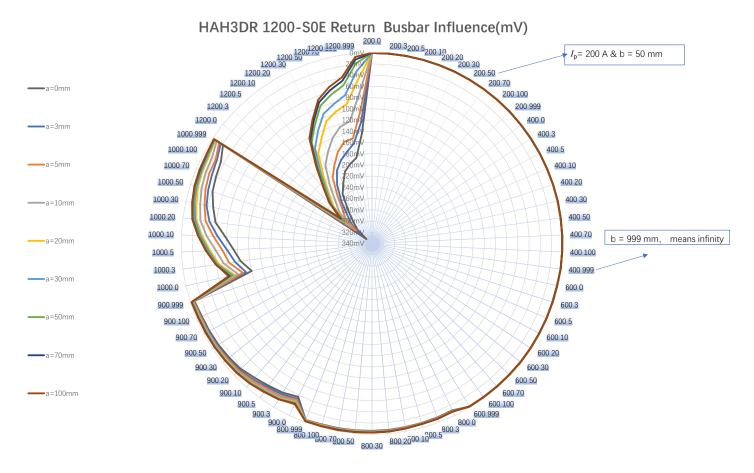
	Total error ε_{tot} specification			
<i>I</i> _P (Α)	$T_{\rm A}$ = 25 °C, $U_{\rm c}$ = 5 V		-40 °C < $T_{\rm A}$ < 125 °C, $U_{\rm c}$ = 5 V	
I _{PM}	90 mV	4.50 %	110 mV	5.50 %
900	50 mV	2.50 %	70 mV	3.50 %
0	20 mV	1.00 %	30 mV	1.50 %
-900	50 mV	2.50 %	70 mV	3.50 %
- I _{P M}	90 mV	4.50 %	110 mV	5.50 %



Return Busbar Influence On Transducer Output

HAH3DR 300-S0E...1200-S0E





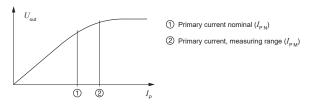
*Return Busbar Influence:

Difference of the $U_{\rm out}$ between the return busbar (U-shape) vs reference (straight busbar).



PERFORMANCES PARAMETERS DEFINITIONS

Primary current definition:



Definition of typical, minimum and maximum values:

Minimum and maximum values for specified limiting and safety conditions have to be understood as such as values shown in "typical" graphs. On the other hand, measured values are part of a statistical distribution that can be specified by an interval with upper and lower limits and a probability for measured values to lie within this interval. Unless otherwise stated (e.g. "100 % tested"), the LEM definition for such intervals designated with "min" and "max" is that the probability for values of samples to lie in this interval is 99.73 %. For a normal (Gaussian) distribution, this corresponds to an interval between -3 sigma and +3 sigma. If "typical" values are not obviously mean or average values, those values are defined to delimit intervals with a probability of 68.27 %, corresponding to an interval between -sigma and +sigma for a normal distribution. Typical, minimum and maximum values are determined during the initial characterization of a product.

Output noise voltage:

The output voltage noise is the result of the noise floor of the Hall elements and the linear amplifier.

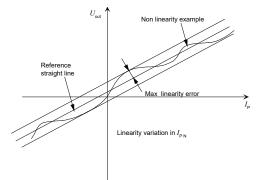
Magnetic offset:

The magnetic offset is the consequence of an any current on the primary side. It's defined after a stated excursion of primary current.

Linearity:

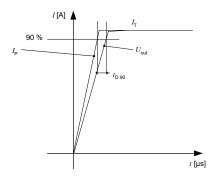
The maximum positive or negative discrepancy with a reference

straight line $U_{out} = f(I_p)$. Unit: linearity (%) expressed with full scale of I_{PN} .



Delay time $t_{D 90}$:

The time between the primary current signal $(I_{P,N})$ and the output signal reach at 90 % of its final value.



Sensitivity:

The transducer's sensitivity S is the slope of the straight line $U_{\text{out}} = f(I_{\text{P}})$, it must establish the relation:

 $U_{\text{out}}(I_{\text{P}}) = U_{\text{C}}/5 (S \times I_{\text{P}} + U_{\text{O}})$

Offset with temperature:

The error of the offset in the operating temperature is the variation of the offset in the temperature considered with the initial offset at 25 °C.

The offset variation $I_{{\rm O}\,{\rm T}}$ is a maximum variation the offset in the temperature range:

$$I_{OT} = I_{OE} \max - I_{OE} \min$$

The offset drift TCI_{OEAV} is the I_{OT} value divided by the temperature range.

Sensitivity with temperature:

The error of the sensitivity in the operating temperature is the relative variation of sensitivity with the temperature considered with the initial offset at 25 °C.

The sensitivity variation S_r is the maximum variation (in ppm or %) of the sensitivity in the temperature range: S_r = (Sensitivity max – Sensitivity min) / Sensitivity at 25 °C. The sensitivity drift TCS_{AV} is the S_T value divided by the temperature range. Deeper and detailed info available is our LEM technical sales offices (www.lem.com).

Offset voltage @ $I_p = 0$ A:

The offset voltage is the output voltage when the primary current is zero. The ideal value of U_0 is $U_c/2$. So, the difference of $U_{o} - U_{c}/2$ is called the total offset voltage error. This offset error can be attributed to the electrical offset (due to the resolution of the ASIC quiescent voltage trimming), the magnetic offset, the thermal drift and the thermal hysteresis. Deeper and detailed info available is our LEM technical sales offices (www.lem. com).

Environmental test specifications:

Refer to LEM GROUP test plan laboratory CO.11.11.515.0 with "Tracking_Test Plan_Auto" sheet.



Environmental test specifications:

HAH3DR 300-S0E...1200-S0E

Name	Standard	Conditions	
	Electrical tests		
Phase delay check	LEM Procedure	100 Hz to 100 kHz @ 20 A peak	
Noise measurement	LEM Procedure	Sweep from DC to 1 MHz	
Delay time d <i>i</i> /d <i>i</i>	LEM Procedure	100 A/μs, <i>I</i> pulse = <i>I</i> _{P max}	
dv/dt	LEM Procedure	5000 V/μs, U = 1000 V	
Dielectric Withstand Voltage test	ISO 16750-2 §4.11 §4.12	2500 V AC / 1 min / 50 Hz	
Insulation resistance	ISO 16750-2 (2010)	500 V DC, time = 60 s $R_{\rm INS} \ge 500 \rm M\Omega$ minimum	
	Environmental tes	ts	
High <i>T</i> °C, High Humidity, Electrical connection	IEC 60068-2-78 (2001)	1000 hours +85 °C/85 % <i>RH</i> $U_{\rm C}$ = 5 V DC, $I_{\rm P}$ = 0	
Thermal Shock	ISO 16750-4 §5.3.2 (04.2010)	1000 cycles (1000 hours), 30 min @ -40 °C , 30 min @ +125 °C U_c not connected, $I_p = 0$	
High <i>T</i> °C Storage + High <i>T</i> °C Exposure	ISO 16750-4 §5.1.2.1 (04.2010)	Storage: 125 °C for 1000 hours $U_{\rm c}$ not connected, $I_{\rm p}$ = 0 for both tests	
Mechanical Shock	ISO 16750-3 §4.2.2 (12.2012)	50 g/ 6 ms Half Sine @ 25 °C 10 shocks of each direction (Total: 60) $U_{\rm c}$ not connected, $I_{\rm p}$ = 0	
Random Vibration in <i>T</i> °C	ISO 16750-3 §4.1.2.4 (12.2012)	ISO 16750-3 §4.1.2.4 96.6 m/s², 22 h/axe, 10 Hz - 2000 Hz	
	EMC tests	1	
Radiated Emission Absorber Lined Shielded Enclosure (ALSE)	CISPR 25	0.15 MHz to 2500 MHz Limit: CISPR 25 (ed 3.0) Class 5 Peak (table 9)	
Radiated Immunity Bulk Current Injection (BCI)	GMW 3097 (2006) §3.4.1 ISO 11452-1 & - 4	1 MHz to 400 MHz Level: Level 2 (table 11)	
Radiated Immunity Anechoic chamber	GMW 3097 (2006) §3.4.2 ISO 11452-1 & - 2	400 MHz to 2000 MHz Level: Level 2 (table 12)	
ESD Test	GMW 3097 (2006) §3.6.3	150 pF / 2000 Ω Contact: ±4 kV, ±6 kV Air: ±8 kV $U_{\rm c}$ not connected	